SHIGA7.032APC PATENT

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant

Hojo et al.

Appl. No.

10/554,380

Filed

: October 26, 2005

For

POSITIVE PHOTORESIST

COMPOSITION AND METHOD

FOR FORMING RESIST

PATTERN

Examiner

A. Eoff

Group Art Unit

1753

OK TO ENTER: /A.E./

04/22/2008

AMENDMENT AND RESPONSE TO FINAL OFFICE ACTION

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Dear Sir:

In response to the final Office Action mailed **January 11, 2008**, Applicants respectfully request the Examiner to enter the following amendments and consider the following remarks.

Amendments to the claims are reflected in the listing of claims which begins on page 2 of this paper.

Remarks begin on page 5 of this paper.